Search Notes

Applica	tion	/Control	No.

Applicant(s)/Patent under Reexamination

10/709,446

LEE ET AL.

Examiner

2627

Matthew G. Kayrish

SEARCHED				
Class	Subclass	Date	Examiner	
720	602	12/19/2005	MK	
369	30.03	5/17/2006	МК	
369	183 189	5/17/2006	MK	
369	231-241	5/17/2006	MK	
369	258.1	5/17/2006	MK	
369	264-268	5/17/2006	MK	
720	695 & 696	5/17/2006	MK	
720	698	5/17/2006	MK	
720	700	5/17/2006	MK	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
360	133	5/17/2006	MK	
369	30.03	5/17/2006	MK	
EAST (USPG-PUB)		5/17/2006	МК	

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST (US-PGPUB, USPAT, USOCR) (See Attached Search History)	12/19/2005	MK
EAST (EPO, JPO, DERWENT, IBM_TDB) (See Attached Search History)	12/19/2005	MK
EAST (US-PGPUB, USPAT, USOCR) (See Attached Search History)	12/23/2005	MK
EAST (USPG-PUB, USPAT, USOCR, EPO, JPO, DERWENT, IBM_TDB) (See Attached Search History)	5/17/2006	MK